	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/045,182	LI ET AL.
Examiner	Art Unit
Michael Y. Won	2155

SEARCHED				
Class	Subclass	Date	Examiner	
709	220, 223, 246, 248	8/22/2006	MVV	
				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARC		·)
	DATE	EXMR
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	8/22/2006	MW
NPL SEARCH: IEEE	8/22/2006	MW
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